

FORM PTO-1449 LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE STATEMENT (use several sheets if necessary)	SERIAL NO.	CASE NO.
	To be Assigned	9281-4692
	FILING DATE	GROUP ART UNIT
	Herewith.	2627
APPLICANT(S): Kiyoshi Sato et al.		

REFERENCE DESIGNATION U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS/ SUBCLASS	FILING DATE
TC	A1	6,256,864	07/2001	Pierre Gaud et al.		
TC	A2	6,335,846	01/2002	Pierre Gaud et al.		

FOREIGN PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	COUNTRY	CLASS/ SUBCLASS	TRANSLATION YES NO
TC	A3	11-273028	10/1999	Japan		X
TC	A4	2002-170205	06/2002	Japan		X
TC	A5	2000-311311	11/2000	Japan		X

EXAMINER INITIAL	OTHER ART (Including Author, Title, Date, Pertinent Pages, etc.)

EXAMINER	/Tianjie Chen/	DATE CONSIDERED	12/21/2006
----------	----------------	-----------------	------------

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.



FORM PTO-1449 LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE STATEMENT (use several sheets if necessary)	SERIAL NO. 10/716,743	CASE NO. 9281-4692
	FILING DATE November 17, 2003	GROUP ART UNIT 2627 0729
	APPLICANT(S): Kiyoshi Sato et al.	

REFERENCE DESIGNATION		U.S. PATENT DOCUMENTS				
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS/ SUBCLASS	FILING DATE

FOREIGN PATENT DOCUMENTS								
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	COUNTRY	CLASS/ SUBCLASS	TRANSLATION		
						YES	NO	
TC	B1	6-103528	04-15-1994	JAPAN		X		
	B2	63-31006	02-09-1988	JAPAN		X		
	B3	2001-266309	09-28-2001	JAPAN		X		
	B4	2000-322709	11-24-2000	JAPAN		X		
	B5	5-250636	09-28-1993	JAPAN		X		
	B6	1-282715	11-14-1989	JAPAN		X		
	B7	4-356707	12-10-1992	JAPAN		X		
TC	B8	6-103531	04-15-1994	JAPAN		X		

EXAMINER INITIAL	OTHER ART (Including Author, Title, Date, Pertinent Pages, etc.)		
TC	B9	Copy of Notification of Refusal for corresponding Japanese Patent Application No. 2003-293379.	

EXAMINER /Tianjie Chen/	DATE CONSIDERED 08/28/2006
-----------------------------------	--------------------------------------

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.